

INFORMATION DISCLOSURE STATEMENT TRANSMITTAL	<table border="1" style="width: 100%; border-collapse: collapse;"> <tr> <td style="width: 50%;"><i>Application Number</i></td> <td></td> </tr> <tr> <td><i>Filing Date</i></td> <td></td> </tr> <tr> <td><i>First Named Inventor</i></td> <td>PINEDA DE GYVEZ, JOSE, D., J.</td> </tr> <tr> <td><i>Group Art Unit</i></td> <td></td> </tr> <tr> <td><i>Examiner Name</i></td> <td></td> </tr> <tr> <td><i>Atty. Docket Number</i></td> <td>NL04 0189 US1</td> </tr> </table>	<i>Application Number</i>		<i>Filing Date</i>		<i>First Named Inventor</i>	PINEDA DE GYVEZ, JOSE, D., J.	<i>Group Art Unit</i>		<i>Examiner Name</i>		<i>Atty. Docket Number</i>	NL04 0189 US1
<i>Application Number</i>													
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<i>First Named Inventor</i>	PINEDA DE GYVEZ, JOSE, D., J.												
<i>Group Art Unit</i>													
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To Commissioner For Patents
Enclosed herewith is a Form PTO-1449, any required copies of documents listed thereon, and any concise explanation of their relevance is indicated below per 37 CFR 1.97.

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number No.-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns Lines, Where Relevant Passages or Relevant Figures Appear
		US-			
		US-			
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FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Document Number (ctry ³ -no.-kind ² , if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of cited document	Pages, Columns Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶

NON-PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in capital letters), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ⁶
	1	SHYAM S. SOMAYAJULA ET AL. : "ANALOGUE FAULT DIAGNOSIS BASED ON RAMPING POWER SUPPLY CURRENT SIGNATURE CLUSTERS"; IEEE TRANSACTIONS ON CIRCUITS AND SYSTEMS: ANALOUGE AND DIGITAL SIGNAL PROCESSING, VOL. 43, NO. 10; OCT 1996 PP 703-712	

Examiner Signature	Date Considered
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* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Unique citation designation number. ² See attached Kinds of U.S. Patent Documents. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the